**FORM PTO-1449** (REV. 7-80)

## U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

SERIAL NO.

**BTEC 9643** 

09/448,927

**APPLICANT** 

Wellinghoff et al.

**FILING DATE** 

**GROUP** 

11/24/99

LIST OF PRIOR ART CITED BY APPLICANT

(Use several sheets if necessary)

## **U.S. PATENT DOCUMENTS**

U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
TA	1	5,244,811	09/1993	Matthews	436	146		
1	2	5,360,609	11/1994	Wellinghoff	514	772.3		
	3	5,501,801	03/1996	Zhang et al.	210	748		
	4	5,616,532	04/1997	Heller et al.	502	242		
	5	5,631,300	05/1997	Wellinghoff	514	772.3		
	6	5,639,295	06/1997	Wellinghoff et al.	106	15.05		
	7	5,650,446	07/1997	Wellinghoff et al.	514	772.3		
	8	5,658,841	08/1997	Tanaka et al.	502	305		
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	10	5,695,814	12/1997	Wellinghoff et al.	427	213		
	11	5,705,092	01/1998	Wellinghoff et al.	252	187.21		
	12	5,707,739	01/1998	Wellinghoff et al.	428	403		
	13	5,736,165	04/1998	Ripley et al.	424	661		
	14	5,849,200	12/1998	Heller et al.	210	748		
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U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. SERIAL NO. **FORM PTO-1449** PATENT AND TRADEMARK OFFICE (REV. 7-80) **BTEC 9643** 09/448,927 **APPLICANT** LIST OF PRIOR ART CITED BY APPLICANT Wellinghoff et al. (Use several sheets if necessary) **FILING DATE GROUP** 11/24/99 PATENT & TR **U.S. PATENT DOCUMENTS cont.** FILING DATE IF APPROPRIATE \*EXAMINER INITIAL **SUBCLASS CLASS** NAME DOCUMENT NO. DATE 514 772.3 07/1999 Wellinghoff et al. 22 5,922,776 428 402 Barenberg et al. 23 5,965,264 10/1999 37 422 11/1999 Barenberg et al. 24 5.980.826 OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.) Frank, et al. "Semiconductor Electrodes. 12. Photoassisted Oxidations and Photoelectrosynthesis at Polycrystalline 25 TiO<sub>2</sub> Electrodes," Journal of the Am. Chemical Society, Vol. 99, No. 14, pp. 4667-4675, 1977. Inoue, et al. "Competitive Photosensitized Oxidation at TiO<sub>2</sub> Photoanode," Chemistry Letters, , pp. 1073-1076, 1977. 26

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	١	LIST OF PRIOR ART CITE	APPLICANT Wellinghoff et al.										
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;	28	5,411,643	5/2/95	Cawlfield et al.	204	715							
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m	32	International Search Report in PCT/US00/10804 dated August 24, 2000 (4 pages).											

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